Searcn Notes			

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/537,910	SHIN, HYO-SOON	
Examiner	Art Unit	
Randall Chin	1744	. • • •

SEARCHED			
Class	Subclass	Date	Examiner
15	191.1		1
15	192	V	
15	193	3/22/2006	RC
MONTED	spen.	8/15/06	Re-
(PONTE)	SREH O SREH	3/1/07	Re
		•	
		·	

INI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
•				
		٠		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST, OCR, EPO, JPO, DERWENT		1
Inventor name search	3/22/2006	RC
·		
·		
		··· <u>·</u>